

Search Notes

Application/Control No.

10/772,167

Examiner

Mark L. Shibuya, Ph.D.

Applicant(s)/Patent under
Reexamination

GONYE ET AL.

Art Unit

1639

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST, term, inventor search		